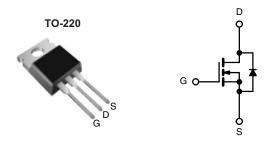


Vishay Siliconix

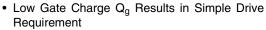
Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	50	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.21				
Q _g (Max.) (nC)	110	110				
Q _{gs} (nC)	33	33				
Q _{gd} (nC)	54	54				
Configuration	Sino	Single				



N-Channel MOSFET

FEATURES





 Improved Gate, Avalanche and Dynamic dV/dt Ruggedness

- RoHS*
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low R_{DS(on)}
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- · High Speed Power Switching
- · Hard Switched and High Frequency Circuits

ORDERING INFORMATION				
Package	TO-220			
Lead (Pb)-free	IRFB20N50KPbF			
Lead (1 b)-nee	SiHFB20N50K-E3			
SnPb	IRFB20N50K			
SHED	SiHFB20N50K			

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	1-	20		
Continuous Drain Current		T _C = 100 °C	I _D	12	Α	
Pulsed Drain Current ^a			I _{DM}	80		
Linear Derating Factor				2.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	330	mJ	
Repetitive Avalanche Current ^a			I _{AR}	20	Α	
Repetitive Avalanche Energy ^a			E _{AR}	28	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	280	W	
Peak Diode Recovery dV/dt ^c			dV/dt	10	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	- °C	
Mounting Torque	6-32 or I	M3 screw		10	N	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. Starting $T_J = 25$ °C, L = 1.6 mH, $R_g = 25 \Omega$, $I_{AS} = 20$ A.
- c. $I_{SD} \le 20$ A, $dI/dt \le 350$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFB20N50K, SiHFB20N50K



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	58			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.45			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referen	ce to 25 °C, I _D = 1 mA	-	0.61	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V _{DS} :	= V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	1	V _{DS} :	V _{DS} = 500 V, V _{GS} = 0 V		-	50	
Zero date voltage Brain Guirent	I _{DSS}	$V_{DS} = 400 \text{V}$	$V_{\rm S} = 0 \ V_{\rm T} = 125 \ ^{\circ}{\rm C}$	-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 12 A ^b	-	0.21	0.25	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 12 A	11	-	-	S
Dynamic							
Input Capacitance	C_{iss}		$V_{GS} = 0 V$,	-	2870	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 V$,	-	320	-	
Reverse Transfer Capacitance	C_{rss}	f = 1	f = 1.0 MHz, see fig. 5		34	-	nE
Output Capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = 1.0 V, f = 1.0 MHz	-	3480	-	pF
			V _{DS} = 400 V, f = 1.0 MHz	-	85	-	
Effective Output Capacitance	Coss eff.		V _{DS} = 0 V to 400 V	-	160	-	
Total Gate Charge	Q_g		I _D = 20 A, V _{DS} = 400 V see fig. 6 and 13 ^b	-	-	110	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	33	
Gate-Drain Charge	Q_{gd}		see lig. 6 and 13	-	-	54	
Turn-On Delay Time	t _{d(on)}	,		-	22	-	
Rise Time	t _r	V_{DD}	= 250 V, I _D = 20 A	=	74	-	no
Turn-Off Delay Time	t _{d(off)}	$R_0 = 7.5 \Omega$	$R_g = 7.5 \Omega$, $V_{GS} = 10 V$, see fig. 10^b		45	-	- ns
Fall Time	t _f	yo 22, v GS - 10 v, 300 llg. 10		-	33	-	
Drain-Source Body Diode Characteristic	s	•					
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the		-	-	20	_
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	80	A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 20 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}$, $I_F = 20 \text{A}$, $dI/dt = 100 \text{A/}\mu\text{s}^b$		-	520	780	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	5.3	8.0	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)				L _D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. Pulse width \leq 400 μ s; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

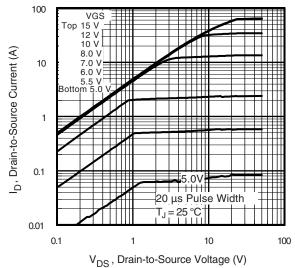


Fig. 1 - Typical Output Characteristics

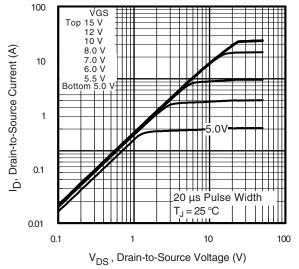


Fig. 2 - Typical Output Characteristics

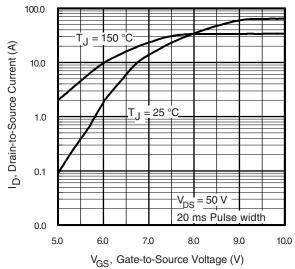


Fig. 3 - Typical Transfer Characteristics

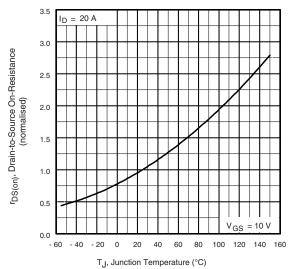


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFB20N50K, SiHFB20N50K



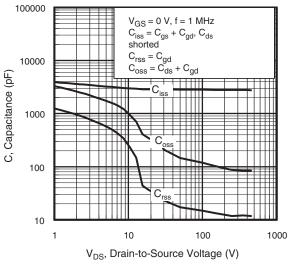


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

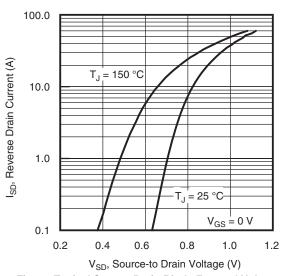


Fig. 7 - Typical Source-Drain Diode Forward Voltage

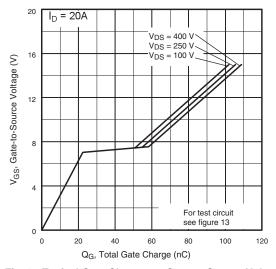


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

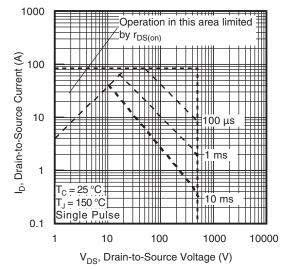


Fig. 8 - Maximum Safe Operating Area



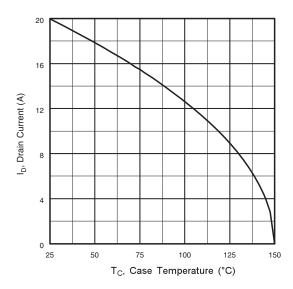


Fig. 9 - Maximum Drain Current vs. Case Temperature

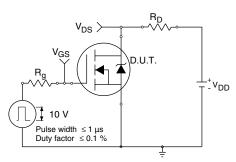


Fig. 10a - Switching Time Test Circuit

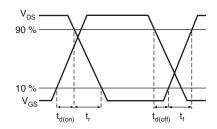


Fig. 10b - Switching Time Waveforms

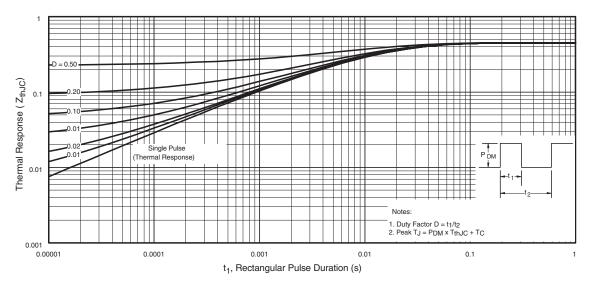


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

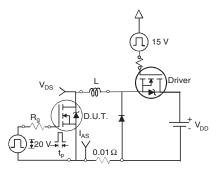


Fig. 12a - Unclamped Inductive Test Circuit

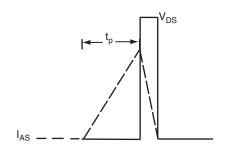


Fig. 12b - Unclamped Inductive Waveforms



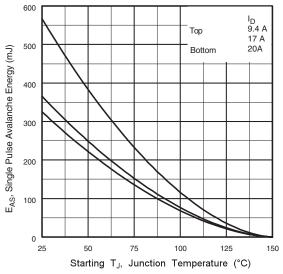


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

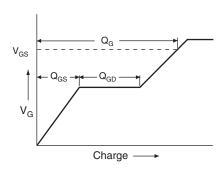


Fig. 13a - Basic Gate Charge Waveform

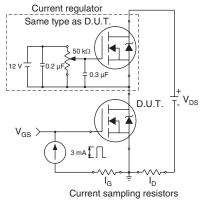
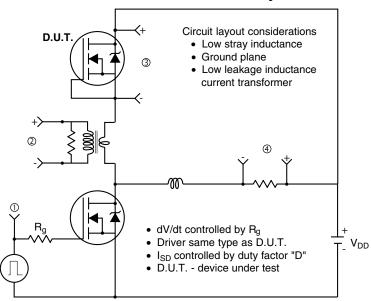


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



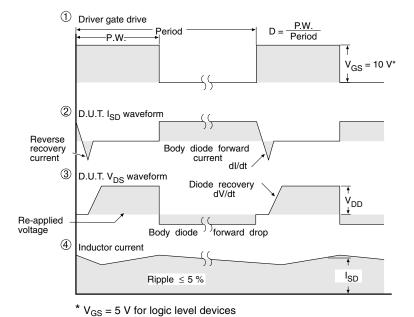


Fig. 14 - For N-Channel

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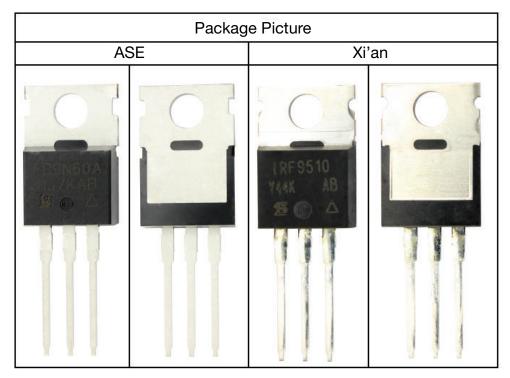
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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